


<b>Search Notes</b>  	<b>Application/Control No.</b>  10528960	<b>Applicant(s)/Patent Under Reexamination</b>  KATAOKA ET AL.
	<b>Examiner</b>  MD. YOUNUS MEAH	<b>Art Unit</b>  1652

SEARCHED			
Class	Subclass	Date	Examiner
			stic

SEARCH NOTES		
Search Notes	Date	Examiner
east, all inventors, scirus, stn, google	95/11/016/08, 4/20/099, 5/11/09	mym
sequences	9/17/08,4/16/09	stic, mym

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
sequences		4/16/09	stic mym

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